

Not for New Design	n
The CT425 is in production but has been determined to NOT FOR NEW DESIGN. This classification indicates this device is currently restricted to existing customer a The device should not be purchased for new design app because obsolescence in the near future is probable. Sa longer available.	es that sale of applications. plications
Date of status change: March 28, 2025	
<b>Recommended Substitutions:</b>	
For existing customer transition, and for new customer cations, refer to CT428.	ers or new appli-
NOTE: For detailed information on purchasing options local Allegro field applications engineer or sales repres	•

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# CT425

### XtremeSense<sup>™</sup> TMR Current Sensor with Ultra-Low Noise and <1% Total Error

#### FEATURES AND BENEFITS

• Integrated contact current sensing for low to medium current ranges:

-	
$\square$ 0 to 20 A	$\square$ 0 to 50 A
$\Box \pm 20 \text{ A}$	$\Box \pm 50  A$
$\square$ 0 to 30 A	$\square$ 0 to 65 A
$\Box \pm 30 \text{ A}$	□ ±65 A

- Integrated current carrying conductor (CCC)
- Linear analog output voltage
- Total error output  $\leq \pm 1.0\%$  FS
- 1 MHz bandwidth
- Response time: 300 ns
- UL/IEC 62368-1 and UL1577 certification
   □ Rated isolation voltage: 3.5 kV<sub>RMS</sub>
  - $\square$  Working voltage for basic isolation: 560 V<sub>RMS</sub>
  - □ Working voltage for reinforced isolation: 280 V<sub>RMS</sub>
- Low noise: 9.0 to 13.5 mA<sub>RMS</sub> @  $f_{BW} = 100 \text{ kHz}$
- Supply voltage: 4.75 to 5.50 V

TÜV Certificate No.:

R 72226133 0001

- Filter function to reduce noise on output pin
- Immunity to common mode fields: -54 dB
- AEC-Q100 grade 1
- 8-lead SOIC package



The CT425 is a high bandwidth and ultra-low noise integrated contact current sensor that uses Allegro patented XtremeSense<sup>TM</sup> TMR technology to enable high accuracy current measurements for many industrial, consumer, and automotive applications. The device supports eight current ranges where the integrated current carrying conductor (CCC) will handle up to 65 A of current and generates a current measurement as a linear analog output voltage. The device achieves a total output error of less than  $\pm 1.0\%$  full-scale (FS).

The device has a 300 ns output response time while the current consumption is  $\sim$ 6.0 mA and is immune to common mode fields. The CT425 has a filter function to reduce the noise on the output pin.

The CT425 is offered in an industry-standard 8-lead SOIC package that is green and RoHS compliant.

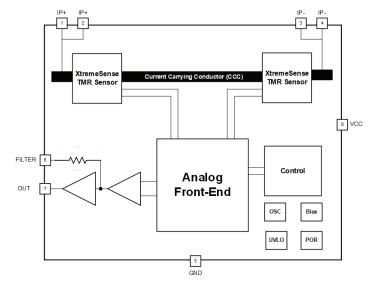
### APPLICATIONS

- Solar/power inverters
- UPS, SMPS, and telecom
   power supplies
- Battery management systems
- Motor control
- White goods
- Power utility meter
- Overcurrent fault protection

PACKAGE:



Not to scale



UL Certificate No.: UL-CA-2201235-0

#### Figure 1: CT425 Functional Block Diagram for 8-lead SOIC Package

#### SELECTION GUIDE

Part Number	Current Range (I <sub>PMAX</sub> ) (A)	Sensitivity (mV/A)	Operating Temperature Range (°C)	Package	Packing
CT425-HSN820MR	±20	100			
CT425-HSN830MR					
CT425-HSN850MR					
CT425-HSN865MR         ±65           CT425-HSN820DR         20	±65	30.8	40 to 125	8-lead SOIC 4.89 mm × 6.00 mm × 1.62 mm	Tape and
	20	200	40 to 125	4.89 mm × 6.00 mm × 1.62 mm	Reel
CT425-HSN830DR	ISN830DR 30 133.3	133.3			
CT425-HSN850DR	425-HSN850DR 50 80				
CT425-HSN865DR	65	61.5			
AEC-Q100 GRADE 1					
CT425-ASN820MR	±20	100			
CT425-ASN830MR	±30	66.7			
CT425-ASN850MR	±50	40			
CT425-ASN865MR	±65	30.8	Grade 1	8-lead SOIC	Tape and
CT425-ASN820DR	20	200	-40 to 125	4.89 mm × 6.00 mm × 1.62 mm	Reel
CT425-ASN830DR	30	133.3	]		
CT425-ASN850DR	CT425-ASN850DR 50		]		
CT425-ASN865DR	65	61.5			

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#### ABSOLUTE MAXIMUM RATINGS [1]

Characteristic	Symbol	Notes	Rating	Unit
Supply Voltage Strength	V <sub>CC</sub>		-0.3 to 6.0	V
Analog Input/Output Pins Maximum Voltage	V <sub>I/O</sub>		-0.3 to V <sub>CC</sub> + 0.3 <sup>[2]</sup>	V
Current Carrying Conductor Maximum Current	I <sub>CCC(MAX)</sub>	$T_A = 25^{\circ}C$	70	А
Dielectric Surge Strength Test Voltage	V <sub>SURGE</sub>	IEC 61000-4-5: Tested $\pm 5$ Pulses at 2/60 seconds, 1.2 µs (rise) and 50 µs (width)	6.0 (min)	kV
Surge Strength Test Current	I <sub>SURGE</sub>	Tested $\pm 5$ Pulses at 3/60 seconds, 8.0 $\mu$ s (rise) and 20 $\mu$ s (width)	3.0 (min)	kA
Electro statio Discharge Drate stien Laurel	ESD	Human Body Model (HBM) per JESD22-A114	±2.0	kV
Electrostatic Discharge Protection Level	ESD	Charged Device Model (CDM) per JESD22-C101	±0.5	kV
Junction Temperature	TJ		-40 to 150	°C
Storage Temperature	T <sub>STG</sub>		-65 to 155	°C
Lead Soldering Temperature	TL	10 seconds	260	°C

[1] Stresses exceeding the absolute maximum ratings may damage the CT425 and may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

 $^{[2]}\mbox{The lower of V}_{CC}\mbox{ + }0.3\mbox{ V or }6.0\mbox{ V}.$ 

#### **RECOMMENDED OPERATING CONDITIONS**<sup>[1]</sup>

Characteristic	Symbol	Notes	Min.	Тур.	Max.	Unit
Supply Voltage Range	V <sub>CC</sub>		4.75	5.00	5.50	V
Output Voltage Range	V <sub>OUT</sub>		0	_	V <sub>CC</sub>	V
Output Current	I <sub>OUT</sub>		_	_	±1.0	mA
Operating Ambient Temperature	т	Extended Industrial	-40	25	125	°C
	IA	Automotive	-40	25	125	°C

<sup>[1]</sup> The Recommended Operating Conditions table defines the conditions for actual operation of the CT425. Recommended operating conditions are specified to ensure optimal performance to the specifications. Allegro does not recommend exceeding them or designing to absolute maximum ratings.



#### **ISOLATION RATINGS**

Characteristic	Symbol	Notes	Rating	Unit
Impulse Withstand Voltage	VIMPULSE	Tested ±5 pulses at 2/minute in compliance to IEC 61000-4-5 $$ 1.2 $\mu s$ (rise) / 50 $\mu s$ (width)	5000	V <sub>PK</sub>
Dielectric Withstand Voltage	V <sub>ISO</sub>	Agency rated for 60 seconds per UL 62368-1:2014 (edition 2) and per UL 1577 $\ensuremath{^{[1]}}$	3500	V <sub>RMS</sub>
Working Voltage for Desig location	V	Maximum approved working voltage for basic insulation according	792	V <sub>PK</sub>
Working Voltage for Basic Isolation	V <sub>WVBI</sub>	to UL 62368-1:2014 (edition 2)	560	V <sub>RMS</sub>
Working Voltage for Deinforged Isolation		Maximum approved working voltage for reinforced insulation	396	V <sub>PK</sub>
Working Voltage for Reinforced Isolation	V <sub>WBRI</sub>	according to UL 62368-1:2014 (edition 2)	280	V <sub>RMS</sub>
Creepage Distance	D <sub>CR</sub>	Minimum distance along package body from IP leads to signal leads.	4	mm
Clearance Distance	D <sub>CL</sub>	Minimum distance through air from IP leads to signal leads	4	mm
Distance Through Isolation	DTI	Minimum internal distance through isolation	110	μm
Comparative Tracking Index	СТІ	Material Group II	400 to 599	V

<sup>[1]</sup> 100% Production-tested for 1 second in accorance with UL 62368-1 (edition 2) and UL 1577.

### **APPLICATION DIAGRAM**

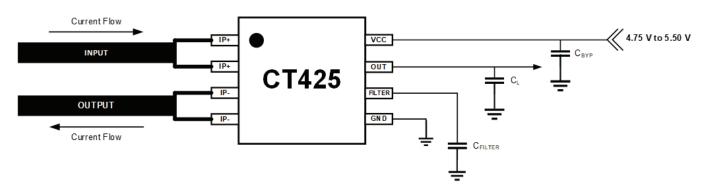


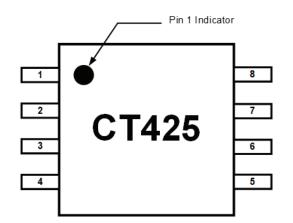
Figure 2: CT425 Application	<b>Block Diagram</b>
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#### **Table 1: Recommended External Components**

Component	Description	Description Vendor and Part Number		Тур.	Max.	Unit
C <sub>BYP</sub>	1.0 µF, X5R or Better	Murata GRM155C81A105KA12	—	1.0	_	μF
C <sub>FILTER</sub>	Various, X5R or Better	Murata	_	See Figure 36	_	nF



### PINOUT DIAGRAM AND TERMINAL LIST





#### **Terminal List**

Number	Name	Function
1, 2	IP+	Input primary conductor (positive).
3, 4	IP-	Output primary conductor (negative).
5	GND	Ground.
6	FILTER	Filter pin to improve noise performance by connecting an external capacitor to set the cut-off frequency. No connect if the FILTER pin is not used.
7	OUT	Analog output voltage that represents the measured current.
8	VCC	Supply voltage.



**ELECTRICAL CHARACTERISTICS:** Valid for V<sub>CC</sub> = 4.75 to 5.50 V, C<sub>BYP</sub> = 1.0  $\mu$ F, and T<sub>A</sub> = -40°C to 125°C, typical values are V<sub>CC</sub> = 5.00 V and T<sub>A</sub> = 25°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
POWER SUPPLIES						
Supply Current	I <sub>CC</sub>	f <sub>BW</sub> = 1 MHz, no load, I <sub>P</sub> = 0 A	-	6.0	9.0	mA
OUT Maximum Drive Capability <sup>[1]</sup>	I <sub>OUT</sub>	OUT covers 10% to 90% of V <sub>CC</sub> span	-1.0	-	+1.0	mA
OUT Capacitive Load <sup>[1]</sup>	C <sub>L_OUT</sub>		-	-	100	pF
OUT Resistive Load [1]	R <sub>L_OUT</sub>		-	100	_	kΩ
Primary Conductor Resistance [1]	R <sub>IP</sub>		-	1	_	mΩ
Power Supply Rejection Ratio <sup>[1]</sup>	PSRR		-	35	_	dB
Sensitivity Power Supply Rejection Ratio <sup>[1]</sup>	SPSRR		-	35	_	dB
Offset Power Supply Rejection Ratio <sup>[1]</sup>	OPSRR		_	40	_	dB
ANALOG OUTPUT (OUT)		·				
OUT Voltage Linear Range, Typical	V <sub>OUT</sub>	$V_{SIG_{AC}} = \pm 2.00 \text{ V}, V_{SIG_{DC}} = +4.00 \text{ V}$	0.50	-	4.50	V
Output High Saturation Voltage	V <sub>OUT_SAT</sub>	$V_{OUT}$ , $T_A = 25^{\circ}C$	V <sub>CC</sub> – 0.30	V <sub>CC</sub> – 0.25	_	V
Common Mode Field Dejection Datis [1]	CMFRR		-	-54	_	dB
Common Mode Field Rejection Ratio [1]	CIVIERR		-	0.5	_	mA/G
TIMINGS						
Power-On Time <sup>[1]</sup>	t <sub>ON</sub>	V <sub>CC</sub> ≥ 2.50 V	-	100	200	μs
Rise Time <sup>[1]</sup>	t <sub>RISE</sub>	$I_P = I_{RANGE(MAX)}, T_A = 25^{\circ}C, C_L = 220 \text{ pF}$	-	200	_	ns
Response Time <sup>[1]</sup>	t <sub>RESPONSE</sub>	$I_P = I_{RANGE(MAX)}, T_A = 25^{\circ}C, C_L = 220 \text{ pF}$	-	300	_	ns
Propagation Delay <sup>[1]</sup>	t <sub>DELAY</sub>	$I_P = I_{RANGE(MAX)}, T_A = 25^{\circ}C, C_L = 220 \text{ pF}$	-	250	_	ns
PROTECTION						
	N/	Rising V <sub>DD</sub>	-	2.50	_	V
Undervoltage Lockout	V <sub>UVLO</sub>	Falling V <sub>DD</sub>	-	2.45	_	V
UVLO Hysteresis	V <sub>UV_HYS</sub>		_	50	_	mV

<sup>[1]</sup> Guaranteed by design and characterization; not tested in production.



# CT425

## XtremeSense<sup>™</sup> TMR Current Sensor with Ultra-Low Noise and <1% Total Error

# ELECTRICAL CHARACTERISTICS $V_{CC} = 5.00 \text{ V}, T_A = 25^{\circ}\text{C}, \text{ and } C_{BYP} = 1.0 \mu\text{F} \text{ (unless otherwise specified)}$

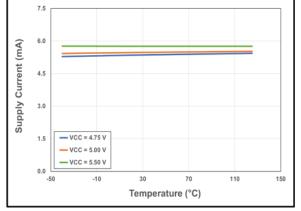


Figure 4: CT425 Supply Current vs. Temperature vs. Supply Voltage

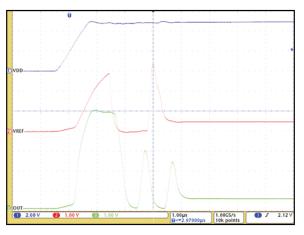


Figure 5: CT425 Startup Waveforms for V<sub>OQ</sub> = 0.50 V (DC Current)

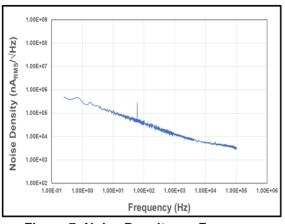


Figure 7: Noise Density vs. Frequency

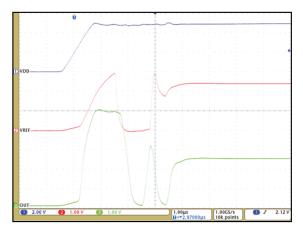


Figure 6: CT425 Startup Waveforms for V<sub>OQ</sub> = 2.50 V (AC Current)



# CT425

### XtremeSense<sup>™</sup> TMR Current Sensor with Ultra-Low Noise and <1% Total Error

#### ELECTRICAL CHARACTERISTICS (continued)

 $V_{CC}$  = 5.00 V, T<sub>A</sub> = 25°C, and C<sub>BYP</sub> = 1.0 µF (unless otherwise specified)

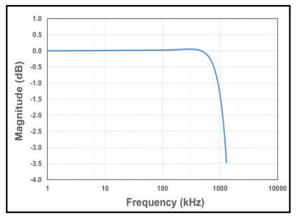


Figure 8: CT425 Bandwidth with C<sub>FILTER</sub> = 1.0 pF

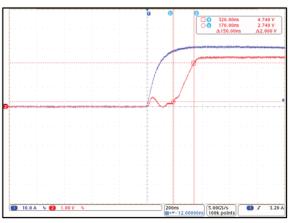


Figure 10: CT425 Rise Time;  $I_P = 30 A_{PK}$  and CL = 100 pF (Blue =  $I_{CCC}$ , Red =  $V_{OUT}$ )

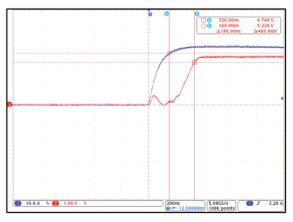


Figure 9: CT425 Response Time;  $I_P = 30 A_{PK}$ and  $C_L = 100 \text{ pF}$  (Blue =  $I_{CCC}$ , Red =  $V_{OUT}$ )

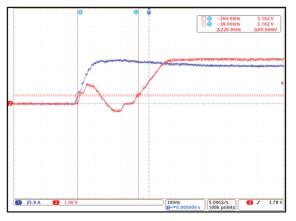


Figure 11: CT425 Propagation Delay;  $I_P = 30 A_{PK}$ and  $C_L = 100 \text{ pF}$  (Blue =  $I_{CCC}$ , Red =  $V_{OUT}$ )



# **CT425-xSN820DR: 0 to 20 A – PERFORMANCE CHARACTERISTICS:** Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF, and $T_A$ = -40°C to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		0	-	20	А
Voltage Output Quiescent	V <sub>OQ</sub>	T <sub>A</sub> = 25°C, I <sub>P</sub> = 0 A	0.495	0.500	0.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	200	_	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	_	MHz
Noise <sup>[1]</sup>	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	-	9.0	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_{P}$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	-	-	±1.0	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.3	_	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	-	±1.7	_	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	-	±1.3	_	%
		I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C	_	±6	_	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	_	±40	_	mV
		$I_{P} = 0 A, T_{A} = -40^{\circ}C$	_	±32	_	mV
LIFETIME DRIFT		·		`		`
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±1.7	_	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±2.6	_	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±45	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



# **CT425-xSN820MR: ±20 A – PERFORMANCE CHARACTERISTICS:** Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF, and $T_A$ = -40°C to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		-20	-	20	А
Voltage Output Quiescent	V <sub>OQ</sub>	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	2.495	2.500	2.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	100	-	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	-	MHz
Noise <sup>[1]</sup>	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	-	10.0	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_{P}$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	_	-	±1.0	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.2	_	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.5	_	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	-	±1.9	-	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	-	±2.1	-	%
		$I_{P} = 0 A, T_{A} = 25^{\circ}C$	-	±5	_	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	_	±17	_	mV
		$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C}$	_	±23	_	mV
LIFETIME DRIFT		·				
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±1.6	_	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±2.7	_	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	-	±25	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



# **CT425-xSN830DR: 0 to 30 A – PERFORMANCE CHARACTERISTICS:** Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF, and $T_A$ = -40°C to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		0	-	30	А
Voltage Output Quiescent	V <sub>OQ</sub>	T <sub>A</sub> = 25°C, I <sub>P</sub> = 0 A	0.495	0.500	0.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	133.3	-	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	-	MHz
Noise <sup>[1]</sup>	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	-	10.0	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_P$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	_	-	±1.0	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.3	_	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.3	-	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	-	±1.4	-	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	-	±1.3	-	%
		I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C	-	±6	-	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	_	±30	_	mV
		$I_{P} = 0 A, T_{A} = -40^{\circ}C$	_	±25	_	mV
LIFETIME DRIFT						
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±1.7	_	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_P = I_{P(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±2.6	_	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±35	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



# **CT425-xSN830MR: ±30 A – PERFORMANCE CHARACTERISTICS:** Valid for V<sub>CC</sub> = 4.75 to 5.50 V, C<sub>BYP</sub> = 1.0 $\mu$ F, and T<sub>A</sub> = -40°C to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		-30	-	30	А
Voltage Output Quiescent	V <sub>OQ</sub>	T <sub>A</sub> = 25°C, I <sub>P</sub> = 0 A	2.495	2.500	2.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	66.7	_	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	_	MHz
Noise <sup>[1]</sup>	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	_	11.5	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_P$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	_	_	±1.0	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.4	_	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	_	±2.1	_	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	_	±1.9	_	%
		I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C	_	±6	_	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	_	±18	_	mV
		$I_{P} = 0 A, T_{A} = -40^{\circ}C$	_	±26	_	mV
LIFETIME DRIFT	~	``````````````````````````````````````	· · ·			^
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_P = I_{P(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±1.6	_	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_P = I_{P(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±2.6	_	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$	_	±28	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



# **CT425-xSN850DR: 0 to 50 A – PERFORMANCE CHARACTERISTICS:** Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF, and $T_A$ = -40°C to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		0	-	50	А
Voltage Output Quiescent	V <sub>OQ</sub>	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	0.495	0.500	0.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	80	_	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	_	MHz
Noise <sup>[1]</sup>	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	-	10.0	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_P$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	-	-	±1.5	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.3	-	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.3	_	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	-	±2.1	-	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	-	±1.8	-	%
		I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C	-	±3	_	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	-	±28	_	mV
		$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C}$	-	±23	_	mV
LIFETIME DRIFT						
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±2.2	-	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±2.6	-	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$	-	±33	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



# **CT425-xSN850MR: ±50 A – PERFORMANCE CHARACTERISTICS:** Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF, and $T_A$ = -40°C to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		-50	-	50	A
Voltage Output Quiescent	V <sub>OQ</sub>	T <sub>A</sub> = 25°C, I <sub>P</sub> = 0 A	2.495	2.500	2.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	40	_	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	_	MHz
Noise [1]	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	_	14.0	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_P$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	_	-	±1.0	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.3	_	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	-	±1.9	_	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	-	±2.0	_	%
		I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C	-	±6	_	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	_	±24	_	mV
		$I_{P} = 0 A, T_{A} = -40^{\circ}C$	_	±28	_	mV
LIFETIME DRIFT		·				
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_P = I_{P(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±1.6	_	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_P = I_{P(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±2.6	_	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±30	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



# **CT425-xSN865DR: 0 to 65 A – PERFORMANCE CHARACTERISTICS:** Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF, and $T_{A}$ = -40°C to 125°C, unless otherwise specified

Symbol **Test Conditions** Min. **Typ.**<sup>[1]</sup> Unit Characteristics Max. 0 **Current Range** \_ А 65 IRANGE  $T_A = 25^{\circ}C, I_P = 0 A$ V Voltage Output Quiescent V<sub>OQ</sub> 0.495 0.500 0.505 Sensitivity S  $I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$ \_ 61.5 mV/A \_ Bandwidth<sup>[1]</sup> Small Signal = -3 dB \_ 1.0 \_ MHz f<sub>BW</sub> Noise<sup>[1]</sup> T<sub>A</sub> = 25°C, f<sub>BW</sub> = 100 kHz 10.0  $e_N$ \_ \_ mA<sub>RMS</sub> **OUT ACCURACY PERFORMANCE** Total Output Error E<sub>TOT</sub>  $I_{\mathsf{P}}$  sweep from  $I_{\mathsf{P}(\mathsf{MIN})}$  to  $I_{\mathsf{P}(\mathsf{MAX})}$ \_ ±1.5 % FS \_ Linearity Error  $I_P = I_{P(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$ ±0.2 \_ % FS E<sub>LIN</sub> \_  $I_P = I_{P(MAX)}, T_A = 25^{\circ}C$ % \_ ±0.3 \_ % Sensitivity Error  $I_{P} = I_{P(MAX)}, T_{A} = 125^{\circ}C$ ±1.9 **E**<sub>SENS</sub> \_ \_  $I_P = I_{P(MAX)}, T_A = -40^{\circ}C$ % \_ ±1.5 \_ I<sub>P</sub> = 0 A, T<sub>A</sub> = 25°C ±5 mV \_ \_ I<sub>P</sub> = 0 A, T<sub>A</sub> = 125°C Offset Voltage Error ±12 mV VOE \_ \_  $I_{P} = 0 A, T_{A} = -40^{\circ}C$ ±18 mV \_ \_ LIFETIME DRIFT Total Error Including Lifetime Drift  $I_P = I_{P(MAX)}$ ,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ ±2.4 % FS \_ E<sub>TOT(DRIFT)</sub> \_ Sensitivity Error Including Lifetime Drift  $I_P = I_{P(MAX)}$ ,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ % \_ ±2.6 \_ E<sub>SENS(DRIFT)</sub> Offset Voltage Error Including Lifetime Drift  $I_P = 0 A$ ,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ mV \_ ±20 V<sub>OE(DRIFT)</sub> \_

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



### CT425-xSN865MR: ±65 A – PERFORMANCE CHARACTERISTICS: Valid for $V_{CC}$ = 4.75 to 5.50 V, $C_{BYP}$ = 1.0 µF,

and  $T_A = -40^{\circ}C$  to 125°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	<b>Typ.</b> <sup>[1]</sup>	Max.	Unit
Current Range	I <sub>RANGE</sub>		-65	-	65	А
Voltage Output Quiescent	V <sub>OQ</sub>	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	2.495	2.500	2.505	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	30.8	-	mV/A
Bandwidth <sup>[1]</sup>	f <sub>BW</sub>	Small Signal = –3 dB	-	1.0	-	MHz
Noise <sup>[1]</sup>	e <sub>N</sub>	T <sub>A</sub> = 25°C, f <sub>BW</sub> = 100 kHz	-	13.5	_	mA <sub>RMS</sub>
OUT ACCURACY PERFORMANCE						
Total Output Error	E <sub>TOT</sub>	$I_{P}$ sweep from $I_{P(MIN)}$ to $I_{P(MAX)}$	-	-	±1.0	% FS
Linearity Error	E <sub>LIN</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.3	_	% FS
		$I_P = I_{P(MAX)}, T_A = 25^{\circ}C$	-	±0.5	_	%
Sensitivity Error	E <sub>SENS</sub>	$I_P = I_{P(MAX)}, T_A = 125^{\circ}C$	-	±1.9	-	%
		$I_P = I_{P(MAX)}, T_A = -40^{\circ}C$	-	±1.9	-	%
		$I_{P} = 0 A, T_{A} = 25^{\circ}C$	-	±4	-	mV
Offset Voltage Error	V <sub>OE</sub>	I <sub>P</sub> = 0 A, T <sub>A</sub> = 125°C	-	±17	_	mV
		$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C}$	-	±19	_	mV
LIFETIME DRIFT	•	<u>.</u>		·	·	
Total Error Including Lifetime Drift	E <sub>TOT(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±1.5	_	% FS
Sensitivity Error Including Lifetime Drift	E <sub>SENS(DRIFT)</sub>	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±2.7	-	%
Offset Voltage Error Including Lifetime Drift	V <sub>OE(DRIFT)</sub>	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	-	±23	_	mV

<sup>[1]</sup> Typicals values are the mean ±3 sigma of production distributions. These are formatted as mean ±3 sigma.



### FUNCTIONAL DESCRIPTION

#### Overview

The CT425 is a high accuracy contact current sensor with an integrated current-carrying conductor that handles up to 65 A. It has high sensitivity and a wide dynamic range with excellent accuracy (low total output error) across temperature. This current sensor supports eight current ranges:

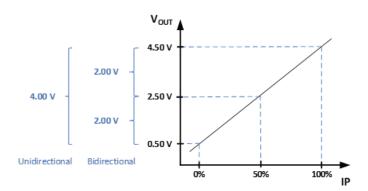
0 to 20 A
±20 A
0 to 30 A
±30 A
0 to 30 A
0 to 65 A
±65 A

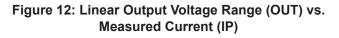
When current is flowing through the current-carrying conductor, the XtremeSense TMR sensors inside the chip senses the field which in turn generates differential voltage signals that then goes through the Analog Front-End (AFE) to output a current measurement with less than  $\pm 1.0\%$  full-scale total output error (E<sub>OUT</sub>).

The chip is designed to enable a fast response time of 300 ns for the current measurement from the OUT pin as the bandwidth for the CT425 is 1.0 MHz. Even with a high bandwidth, the chip consumes a minimal amount of power.

#### Linear Output Current Measurement

The CT425 provides a continuous linear analog output voltage which represents the current measurement. The output voltage range of OUT is from 0.50 to 4.50 V with a  $V_{OQ}$  of 0.50 V and 2.50 V for unidirectional and bidirectional currents, respectively. Figure 12 illustrates the output voltage range of the OUT pin as a function of the measured current.

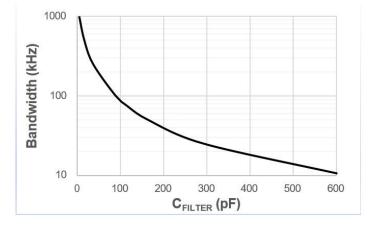




### Filter Function (FILTER)

The CT425 has a pin for the FILTER function which will enable it to improve the noise performance by changing the cutoff frequency. The bandwidth of the CT425 is 1.0 MHz; however, adding a capacitor to the FILTER pin—which will be in-series with an internal resistance of approximately 15 k $\Omega$ —will set the cutoff frequency to reduce noise.

Experimentally measured Bandwidth does not necessarily match the calculated bandwidth value obtained by using the equation  $f_{BW} = \frac{1}{2\pi RC}$  because of the parasitic capacitances due to PCB manufacturing and layout. This is further impacted by the small, picofarad level C<sub>FILTER</sub> recommendations.



#### Figure 13: Experimental Bandwidth vs. C<sub>FILTER</sub>

#### Sensitivity

Sensitivity (S) is a change in the CT425 output in response to a change in 1 A of current flowing through the current-carrying conductor. It is defined by the product of the magnetic circuit sensitivity (G/A, where 1.0 G = 0.1 mT) and the chip linear amplifier gain (mV/G). Therefore, the result of this gives a sensitivity unit of mV/A. The CT425 is factory-calibrated to optimize the sensitivity for the full scale of the device dynamic range.

### **Total Output Error**

The Total Output Error  $(E_{OUT})$  is the maximum deviation of the sensor output from the ideal sensor transfer curve over the full temperature range relative to the sensor full scale.

The Total Output Error is measured by performing a full-scale primary current (IP) sweep and measuring  $V_{OUT}$  at multiple points.

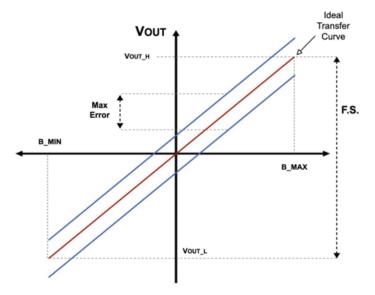


$$E_{OUT} = 100 * \frac{\max\left(V_{OUT_{IDEAL}}(l) - V_{OUT}(l)\right)}{F.S.}$$

The Ideal Transfer Curve is calculated based on datasheet parameters as described below.

$$V_{OUT_{IDEAL}}(I_P) = V_{OQ} + S * I_P$$

 $E_{OUT}$  incorporates all sources of error and is a function of the sensed current (I<sub>p</sub>) from the current sensor.



#### Figure 14: Total Output Error (EOUT) vs. Sensed Current (IP)

The CT425 achieves a total output error  $(E_{OUT})$  that is less than  $\pm 1.0\%$  of Full-Scale (FS) over supply voltage and temperature. It is designed with innovative and proprietary TMR sensors and circuit blocks to provide very accurate current measurements regardless of the operating conditions.

#### **Sensitivity Error**

The sensitivity error ( $E_{SENS}$ ) is the sensitivity temperature drift error for unipolar or DC current. It is calculated using the equation below:

$$E_{SENS} = 100 \times \left(\frac{S_{MEASURED}}{S} - 1\right)$$

For bipolar or AC current, the  $\mathrm{E}_{\mathrm{SENS}}$  is calculated by dividing the equation by 2.

### Power-On Time (t<sub>ON</sub>)

Power-On Time ( $t_{ON}$ ) of 100 µs is the amount of time required by CT425 to start up, fully power the chip, and becoming fully operational from the moment the supply voltage is applied to it. This time includes the ramp-up time and the settling time (within 10% of steady-state voltage under an applied magnetic field) after the power supply has reached the minimum  $V_{CC}$ .

### Response Time (t<sub>RESPONSE</sub>)

Response Time ( $t_{RESPONSE}$ ) of 300 ns for the CT425 is the time interval between the following terms:

- 1. When the primary current signal reaches 90% of its final value,
- 2. When the chip reaches 90% of its output corresponding to the applied current.

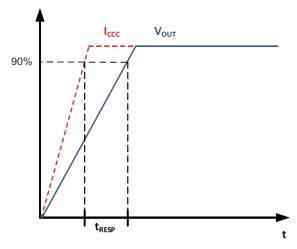


Figure 15: CT425 Response Time Curve

#### Rise Time (t<sub>RISE</sub>)

Rise Time ( $t_{RISE}$ ) is the time interval of when it reaches 10% and 90% of the full-scale output voltage. The  $t_{RISE}$  of the CT425 is 200 ns.

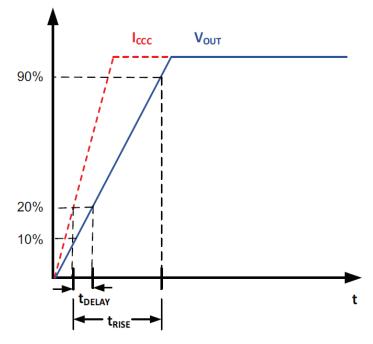
### Propagation Delay (t<sub>DELAY</sub>)

Propagation Delay  $(t_{DELAY})$  is the time difference between these two events:

- 1. When the primary current reaches 20% of its final value
- 2. When the chip reaches 20% of its output corresponding to the applied current.

The CT425 has a propagation delay of 250 ns.





#### Figure 16: CT425 Propagation Delay and Rise Time Curve

### Undervoltage Lockout (UVLO)

The Undervoltage Lockout protection circuitry of the CT425 is activated when the supply voltage ( $V_{CC}$ ) falls below 2.45 V. The CT425 remains in a low quiescent state until  $V_{CC}$  rises above the UVLO threshold (2.50 V). In this condition where  $V_{CC}$  is less than 2.45 V and UVLO is triggered, the output from the CT425 is not valid.

#### **Immunity to Common Mode Fields**

The CT425 is housed in a custom plastic package that uses a U-shaped leadframe to reduce the common mode fields generated as current flows through the current-carrying conductor. With the U-shaped leadframe, the stray fields cancel one another thus reducing electromagnetic interference (EMI).

Also, a good PCB layout of the CT425 will optimize performance and reduce EMI. See the Applications Information section in this datasheet for recommendations on PCB layout.

#### **Creepage and Clearance**

Two important terms as it relates to isolation provided by the package are: creepage and clearance. Creepage is defined as the shortest distance across the surface of the package from one side the leads to the other side of the leads. The definition for clearance is the shortest distance between the leads of opposite side through the air.

### Application

The CT425 is an integrated contact current sensor that can be used in many applications from measuring current in power supplies to motor control to overcurrent fault protection. It is a plugand-play solution in that no calibration is required, and it outputs to a microcontroller a simple linear analog output voltage which corresponds to a current measurement value.

It is designed to support an operating voltage range of 4.75 to 5.50 V, but it is ideal to use a 5.0 V power supply where the output tolerance is less than  $\pm 5\%$ .

### **Bypass Capacitor**

A single 1.0  $\mu$ F capacitor is needed for the VCC pin to reduce the noise from the power supply and other circuits. This capacitor should be placed as close as possible to the CT425 to minimize inductance and resistance between the two devices.

#### **Filter Capacitor**

A capacitor may be added to the FILTER pin of the CT425 if there is a requirement to improve the noise performance. The capacitor will be connected to an internal resistor of 15 k $\Omega$  inside the chip to form a R-C filter. This R-C filter produces a cutoff frequency that will reduce the noise over this lower bandwidth.

If the filtering function is not required, then the FILTER pin should be left unconnected (No Connect).



#### **Recommended PCB Layout**

Since the CT425 can measure up to 65 A of current, special care must be taken in the printed circuit board (PCB) layout of the CT425 and the surrounding circuitry. It is recommended that the CCC pins be connected to as much copper area as possible. It is also recommended that 2 oz. or heavier copper be used for PCB traces when the CT425 is used to measure up to 30 A of current. Additional layers of the PCB should also be used to carry current and be connected using the arrangement of vias. Figure 17 and Figure 18 show the recommended the PCB layout for the 20 A and 30 A variants of CT425. For the 65 A variant, it is recommended that 4 oz. of copper be used for the PCB traces.

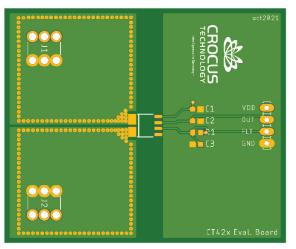


Figure 17: Recommended PCB Layout (Top Layer) for the 20 A to 65 A variants of the CT425

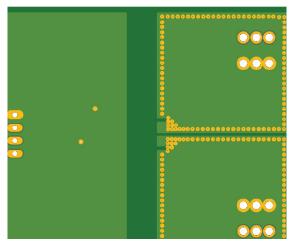


Figure 18: Recommended PCB Layout (Bottom Layer) for the 20 A to 65 A variants of the CT425

#### Thermal Rise vs. Primary Current

Self-heating due to the flow of current should be considered during the design of any current sensing system. The sensor, printed circuit board (PCB), and contacts to the PCB will generate heat as current moves through the system.

The thermal response is highly dependent on PCB layout, copper thickness, cooling techniques, and the profile of the injected current.

The current profile includes peak current, current on-time, and duty cycle. While the data presented in this section was collected with direct current (DC), these numbers may be used to approximate thermal response for both AC signals and current pulses.

The plot in Figure 19 shows the measured rise in steady-state die temperature of the current sensor versus continuous current at an ambient temperature,  $T_A$ , of 25 °C. The thermal offset curves may be directly applied to other values of  $T_A$ .

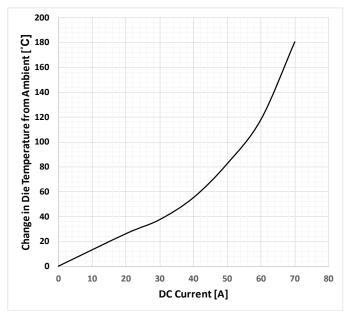


Figure 19: Self Heating in the LA Package Due to Current Flow



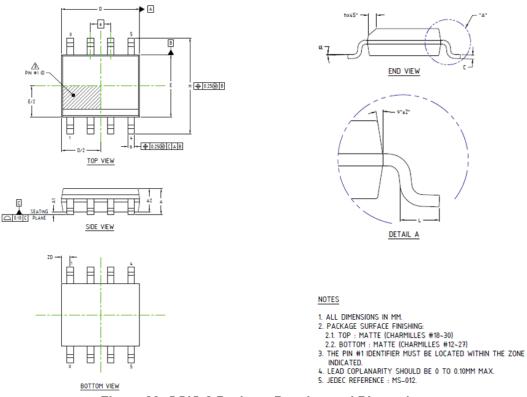
CT425

### XtremeSense<sup>™</sup> TMR Current Sensor with Ultra-Low Noise and <1% Total Error

#### PACKAGE OUTLINE DRAWING

#### For Reference Only – Not for Tooling Use Dimensions in millimeters – NOT TO SCALE mensions exclusive of mold flash, gate burs, and dambar protruction

Dimensions exclusive of mold flash, gate burs, and dambar protrusions Exact case and lead configuration at supplier discretion within limits shown





#### Table 2: CT425 SOIC-8 Package Dimensions

Queen bal		Dimensions in Millimeters (mm)					
Symbol	Min.	Тур.	Max.				
A1	0.10	0.18	0.25				
b	0.36	0.41	0.46				
С	0.19	0.22	0.25				
D	4.80	4.89	4.98				
E	3.81	3.90	3.99				
e	1.27 BSC						
Н	5.80	6.00	6.20				
h	0.25	0.37	0.50				
L	0.41	-	1.27				
A	1.52	1.62	1.72				
α	0°	-	8°				
ZD	0.53 REF						
A2	1.37	1.47	1.57				



# CT425

## XtremeSense<sup>™</sup> TMR Current Sensor with Ultra-Low Noise and <1% Total Error

#### TAPE AND REEL POCKET DRAWING AND DIMENSIONS

For Reference Only – Not for Tooling Use Dimensions in millimeters – NOT TO SCALE Dimensions exclusive of mold flash, gate burs, and dambar protrusions Exact case and lead configuration at supplier discretion within limits shown

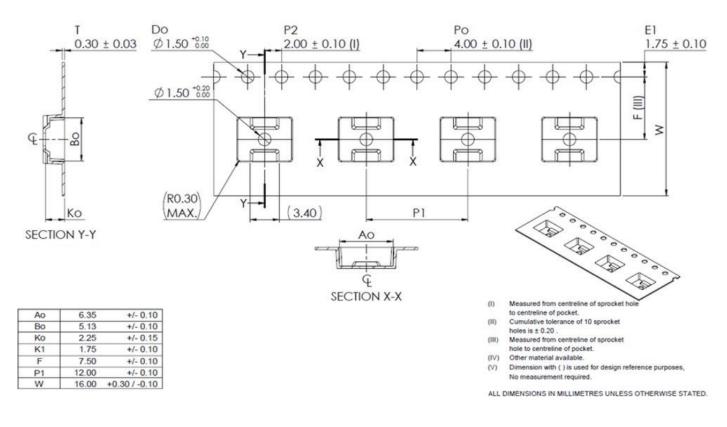


Figure 21: Tape and Pocket Drawing for SOIC-8 Package



#### PACKAGE INFORMATION

#### Table 3: CT425 Package Information

Part Number	Package Type	# of Leads	Package Quantity	Lead Finish	MSL Rating <sup>[2]</sup>	Operating Temperature (°C) <sup>[3]</sup>	Device Marking <sup>[4]</sup>
CT425-HSN820DR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S820DR YYWWLL
CT425-ASN820DR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S820DR YYWWLL
CT425-HSN820MR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S820MR YYWWLL
CT425-ASN820MR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S820MR YYWWLL
CT425-HSN830DR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S830DR YYWWLL
CT425-ASN830DR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S830DR YYWWLL
CT425-HSN830MR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S830MR YYWWLL
CT425-ASN830MR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S830MR YYWWLL
CT425-HSN850DR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S850DR YYWWLL
CT425-ASN850DR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S850DR YYWWLL
CT425-HSN850MR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S850MR YYWWLL
CT425-ASN850MR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S850MR YYWWLL
CT425-HSN865DR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S865DR YYWWLL
CT425-ASN865DR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S865DR YYWWLL
CT425-HSN865MR	SOIC	8	2000	Sn	3	-40 to 125	CT425 S865MR YYWWLL
CT425-ASN865MR	SOIC	8	2000	Sn	3	-40 to 125	CT425A S865MR YYWWLL

[1] RoHS is defined as semiconductor products that are compliant to the current EU RoHS requirements. It also will meet the requirement that RoHS substances do not exceed 0.1% by weight in homogeneous materials. Green is defined as the content of chlorine (CI), bromine (Br), and antimony trioxide based flame retardants satisfy JS709B low halogen requirements of ≤ 1,000 ppm.

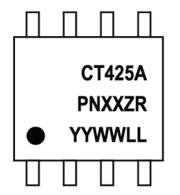
<sup>[2]</sup> MSL Rating = Moisture Sensitivity Level Rating as defined by JEDEC standard classifications.

<sup>[3]</sup> Package will withstand ambient temperature range of -40°C to 125°C and storage temperature range of -65°C to 150°C.

<sup>[4]</sup> Device Marking for CT425 is defined as CT425 S8xxZR YYWWLL where the first 2 lines = part number, YY = year, WW = work week, and LL = lot code.



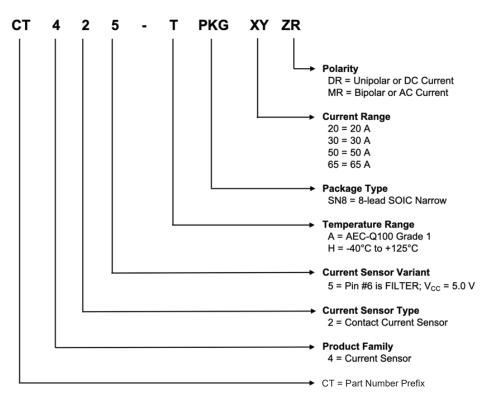
### **DEVICE MARKING**



Row No.	Code	Definition
3	•	Pin 1 Indicator
1	CT425	Allegro Part Number
1	А	AEC-Q100 Qualified
2	Р	Package Type
2	N	Number of Pins
2	XX	Current Range
2	ZR	Polarity
3	YY	Calendar Year
3	WW	Work Week
3	LL	Lot Code

Table 4: CT425 Device Marking Definition for 8-lead SOIC Package

Figure 22: CT425 Device Marking for 8-lead Package



### PART ORDERING NUMBER LEGEND



#### **Revision History**

Number	Date	Description
2	November 2, 2023	Document rebranded and minor editorial updates
3	April 26, 2024	Updated Description and Features and Benefits (page 1); updated Table of Contents (page 2); removed Thermal Characteristics table (page 3); removed IEC 61000 reference (pages 1 and 3); updated Isolation Ratings table (page 4); updated Total Output Error values (pages 13 and 15); added Thermal Rise vs. Primary Current section (page 20); removed performance graph pages.
4	May 2, 2024	Updated Primary Conductor Resistance value (page 6).
5	June 4, 2024	Added notes to package drawings (pages 21 and 22).
6	March 27, 2025	Updated product status to not for new design (cover sheet) and removed reference to evaluation board from table of contents (page 2)

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